Notice of References Cited Application/Control No. 10/042,082 Examiner Tse Chen Applicant(s)/Patent Under Reexamination ABERNATHY ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,611,920 B1	08-2003	Fletcher et al.	713/322
	В	US-6,304,125	10-2001	Sutherland, Ivan E.	327/295
	O	US-5,987,620	11-1999	Tran, Thang	713/600
	D	US-6,393,579	05-2002	Piazza, Thomas A.	713/600
	E	US-6,629,250	09-2003	Kopser et al.	713/401
	F	US-6,651,176 B1	11-2003	Soltis et al.	713/300
	G	US-6,564,328 B1	05-2003	Grochowski et al.	713/320
	Н	US-2002/0103962	08-2002	Toda, Haruki	711/105
	1	US-6,553,473	04-2003	Gaskins et al.	711/169
	J	US-5,783,958	07-1998	Lysinger, Mark A.	327/202
	К	US-5,889,979	03-1999	Miller et al.	713/503
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Р					
	Q					
	R					
	S					
	τ					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	W	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.